

**Supporting information for**

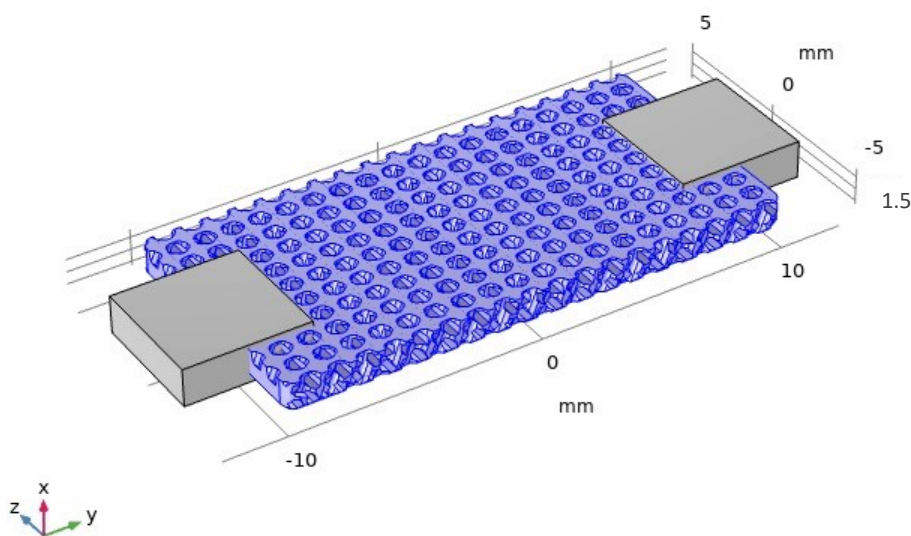
**Three-Dimensional Nano-folded Transition-Metal Oxide Electrode Materials for High-Performing Electrochemical Energy Storage Devices**

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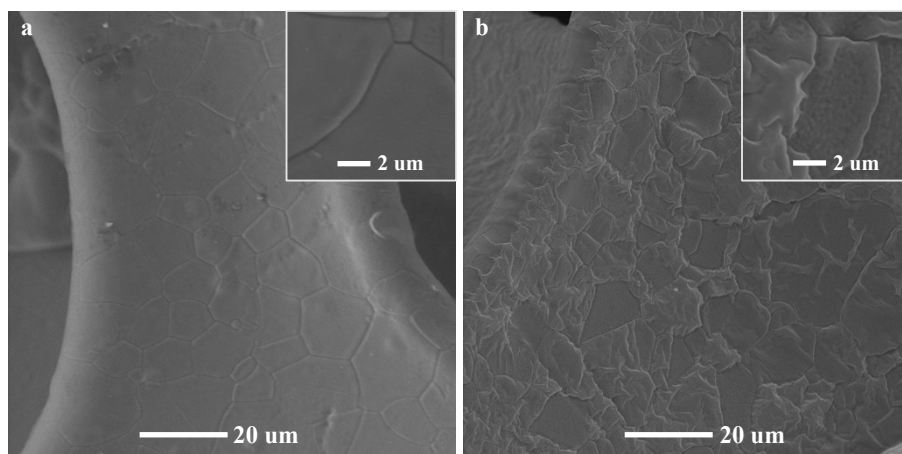
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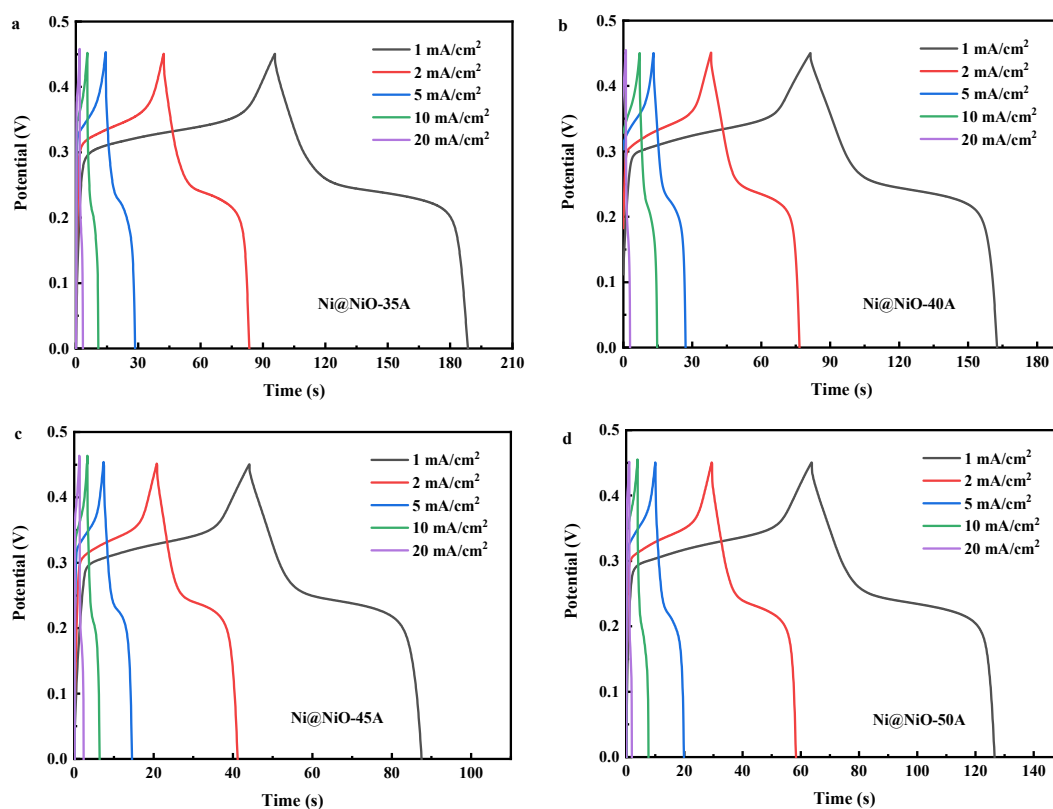
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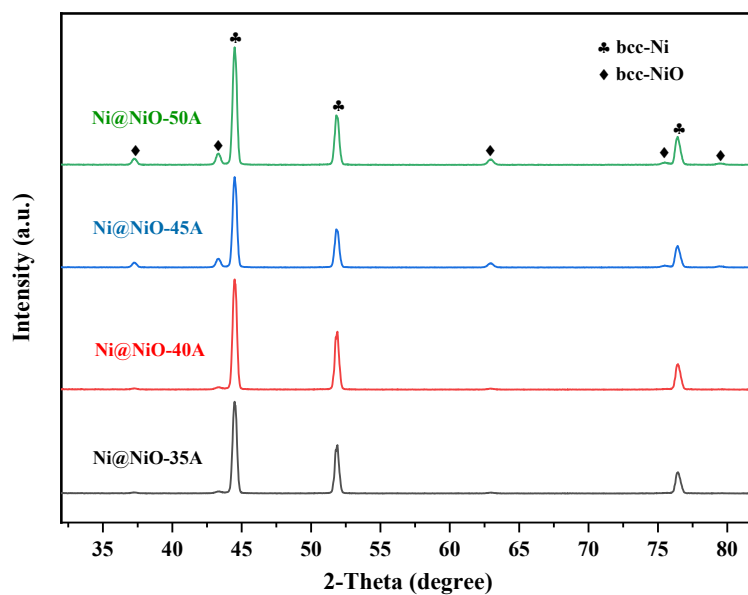
**Figure S1.** The model and geometry parameters for the dynamic thermal oxidation.



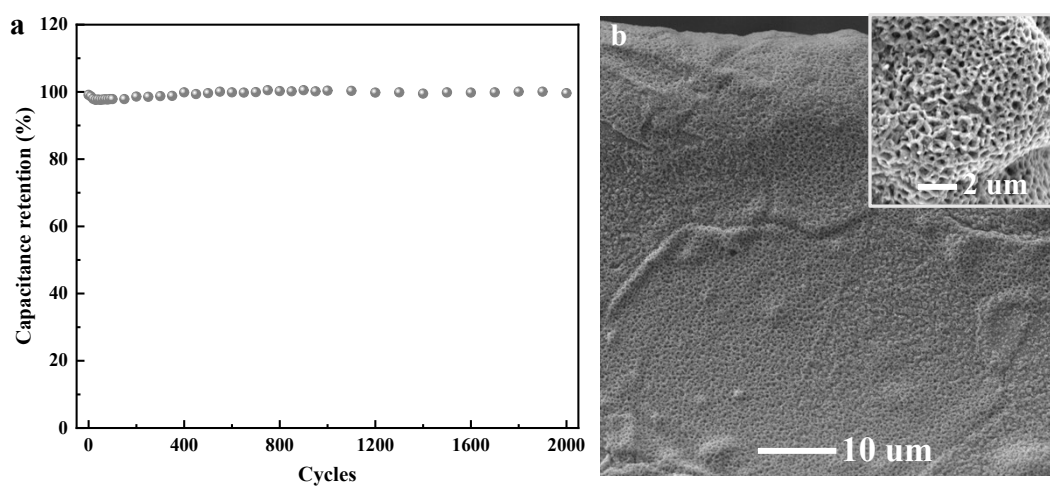
**Figure S2.** The morphological evolutions of the Ni foam before and after dynamic thermal oxidation. (a) representative SEM images of Ni foam after metallographic corrosion; (b) the view of Ni foam after dynamic thermal oxidation.



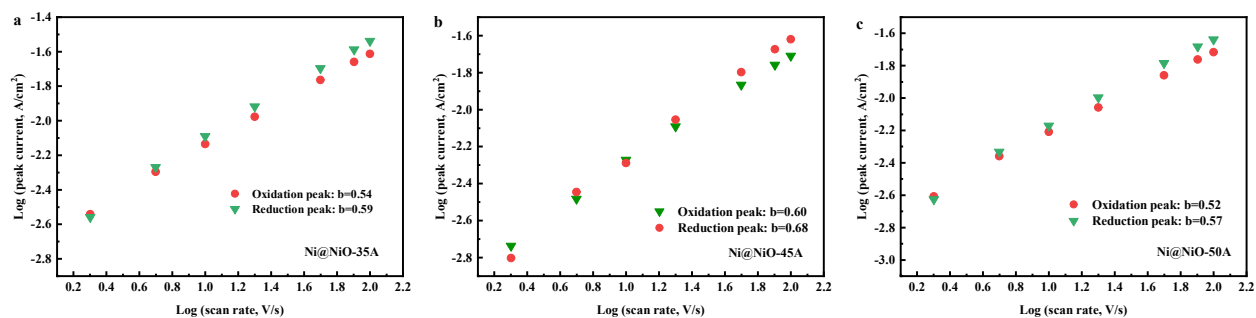
**Figure S3.** GCD curves of 3D nano-folded Ni@NiO freestanding electrode obtained at different dynamic thermal oxidation stages: (a) Ni@NiO-35A; (b) Ni@NiO-40A; (c) Ni@NiO-45A; (d) Ni@NiO-50A).



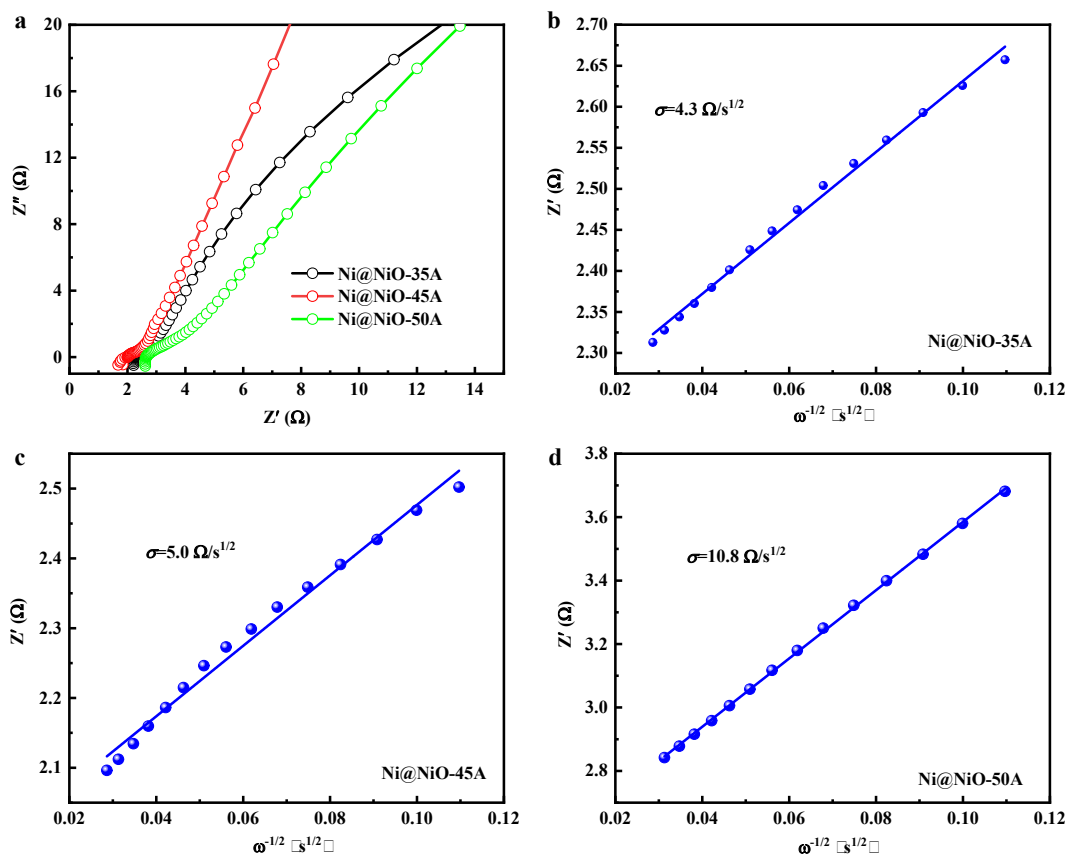
**Figure S4.** XRD pattern of the 3D nano-folded Ni@NiO obtained at different conditions.



**Figure S5.** The cycling performance and morphological evolution of the Ni@NiO-40A electrode. (a) Capacitance retention with the cycling operations; (b) representative SEM view of the Ni@NiO-40A electrode after 2000 cycles.



**Figure S6.** The oxidation and reduction peak derived  $b$ -value at different scan rates of the 3D nano-folded Ni@NiO freestanding electrode obtained at different dynamic thermal oxidation stages.



**Figure S7.** Electrochemical kinetics of the 3D nano-folded Ni@NiO freestanding electrode obtained at different dynamic thermal oxidation stages. (a) EIS spectrum of the different samples; (b-c) The relationship between  $Z'$  and the reciprocal of the square root of frequency ( $\omega^{-1/2}$ ) in the intermediate frequency range.

**Table S1.** NiO coverage and stoichiometric analysis in the 3D nano-folded Ni@NiO obtained at different condition.

Samples	Spot 1	Spot 2	Spot 3	Spot 4	Spot 5	Spot 6	Average
Ni@NiO-35A	1.15	1.02	0.98	1.09	1.03	1.21	1.08
Ni@NiO-40A	1.04	0.96	1.01	1.05	0.98	1.03	1.01
Ni@NiO-45A	0.94	0.92	1.06	0.97	0.89	1.01	0.97
Ni@NiO-50A	0.98	0.86	0.92	1.03	0.96	0.94	0.95

**Table S2.** Electrochemical performance of recent reported NiO-based electrode materials.

Electrodes	Capacitance	Rate performance	Ref.
3D nano-folded Ni@NiO	0.23 F/cm <sup>2</sup> at 2 mV/s (~295 F/g)	50% (from 2 mV/s to 50 mV/s)	Our work
NiO-carbon cloth	132 F/g at 5 mV/s	32% (from 5 mV/s to 50 mV/s)	[1]
NiO Fine Nanoparticles	243 F/g at 2 mV/s	33% (from 2 mV/s to 50 mV/s)	[2]
NiO Nanoflakes	263 F/g at 5 mV/s	48% (from 2 mV/s to 50 mV/s)	[3]

The mass loading of the electrochemical active NiO in the 3D nano-folded Ni@NiO can be calculated by weighting the mass changes of Ni nanofoams before and after oxidation, which was operated by a microbalance (Mettler, XS105DU) with an accuracy of 0.01 mg. Due to the oxidation formula  $2\text{Ni} + \text{O}_2 \rightarrow 2\text{NiO}$ , the weights of NiO ( $m_{\text{NiO}}$ ) in the final product 3D nano-folded Ni@NiO can be derived from  $m_{\text{NiO}} = \Delta m * 74.69/16$  ( $\Delta m$  denotes the weight difference

of Ni nanofoams before and after oxidation). Accordingly, the mass loading of electrochemical active NiO in the 3D nano-folded Ni@NiO obtained at different condition was calculated as listed in the Table S1.

**Table S3.** NiO contents in the 3D nano-folded Ni@NiO obtained at different condition.

	Ni@NiO-35A	Ni@NiO-40A	Ni@NiO-45A	Ni@NiO-50A
$m_{\text{NiO}}$ (mg)	0.47	0.78	0.97	1.35
NiO Content percentage	7.8%	13%	16.2%	22.5%

## Reference

- 1 S. D. Dhas, P. S. Maldar, M. D. Patil, A. B. Nagare, M. R. Waikar, R. G. Sonkawade and A. V. Moholkar, *Vacuum*, 2020, **181**, 109646.
- 2 M. P. Yeager, D. Su, N. S. Marinković and X. Teng, *J. Electrochem. Soc.*, 2012, **159**, A1598-A1603.
- 3 S. Vijayakumar, S. Nagamuthu and G. Muralidharan, *ACS Appl. Mater. Interfaces*, 2013, **5**, 2188-2196.